

## Programmable Skew Clock Buffer

### Features

- All output pair skew <100 ps typical (250 max.)
- 3.75- to 80-MHz output operation
- User-selectable output functions
  - Selectable skew to 18 ns
  - Inverted and non-inverted
  - Operation at  $\frac{1}{2}$  and  $\frac{1}{4}$  input frequency
  - Operation at 2x and 4x input frequency (input as low as 3.75 MHz)
- Zero input to output delay
- 50% duty-cycle outputs
- Outputs drive 50 $\Omega$  terminated lines
- Low operating current
- 32-pin PLCC/LCC package
- Jitter < 200 ps peak-to-peak (< 25 ps RMS)
- Compatible with a Pentium™-based processor

### Functional Description

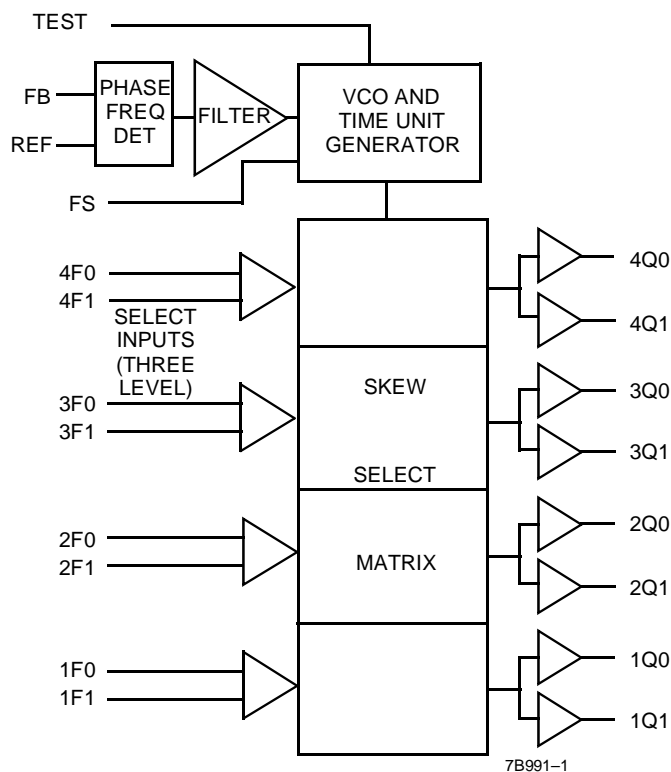
The CY7B991 and CY7B992 Programmable Skew Clock Buffers (PSCB) offer user-selectable control over system clock

functions. These multiple-output clock drivers provide the system integrator with functions necessary to optimize the timing of high-performance computer systems. Eight individual drivers, arranged as four pairs of user-controllable outputs, can each drive terminated transmission lines with impedances as low as 50 $\Omega$  while delivering minimal and specified output skews and full-swing logic levels (CY7B991 TTL or CY7B992 CMOS).

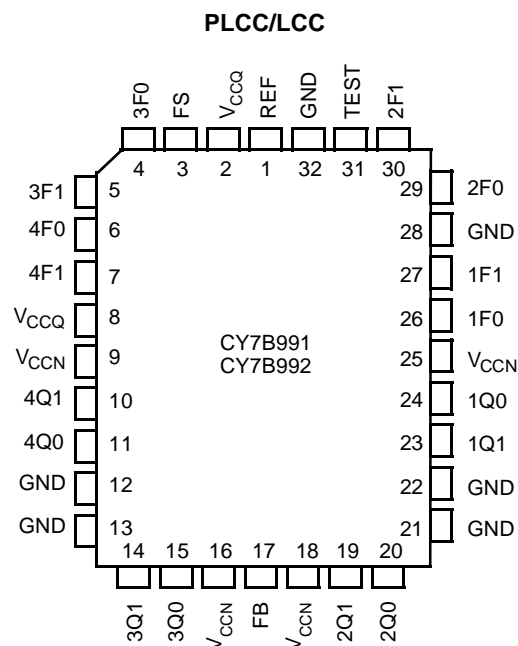
Each output can be hardwired to one of nine delay or function configurations. Delay increments of 0.7 to 1.5 ns are determined by the operating frequency with outputs able to skew up to  $\pm 6$  time units from their nominal "zero" skew position. The completely integrated PLL allows external load and transmission line delay effects to be canceled. When this "zero delay" capability of the PSCB is combined with the selectable output skew functions, the user can create output-to-output delays of up to  $\pm 12$  time units.

Divide-by-two and divide-by-four output functions are provided for additional flexibility in designing complex clock systems. When combined with the internal PLL, these divide functions allow distribution of a low-frequency clock that can be multiplied by two or four at the clock destination. This facility minimizes clock distribution difficulty while allowing maximum system clock speed and flexibility.

### Logic Block Diagram



### Pin Configuration



Pentium is a trademark of Intel Corporation.

## Pin Definitions

Signal Name	I/O	Description
REF	I	Reference frequency input. This input supplies the frequency and timing against which all functional variation is measured.
FB	I	PLL feedback input (typically connected to one of the eight outputs).
FS	I	Three-level frequency range select. See <i>Table 1</i> .
1F0, 1F1	I	Three-level function select inputs for output pair 1 (1Q0, 1Q1). See <i>Table 2</i> .
2F0, 2F1	I	Three-level function select inputs for output pair 2 (2Q0, 2Q1). See <i>Table 2</i> .
3F0, 3F1	I	Three-level function select inputs for output pair 3 (3Q0, 3Q1). See <i>Table 2</i> .
4F0, 4F1	I	Three-level function select inputs for output pair 4 (4Q0, 4Q1). See <i>Table 2</i> .
TEST	I	Three-level select. See test mode section under the block diagram descriptions.
1Q0, 1Q1	O	Output pair 1. See <i>Table 2</i> .
2Q0, 2Q1	O	Output pair 2. See <i>Table 2</i> .
3Q0, 3Q1	O	Output pair 3. See <i>Table 2</i> .
4Q0, 4Q1	O	Output pair 4. See <i>Table 2</i> .
V <sub>CCN</sub>	PWR	Power supply for output drivers.
V <sub>CCQ</sub>	PWR	Power supply for internal circuitry.
GND	PWR	Ground.

## Block Diagram Description

### Phase Frequency Detector and Filter

These two blocks accept inputs from the reference frequency (REF) input and the feedback (FB) input and generate correction information to control the frequency of the Voltage-Controlled Oscillator (VCO). These blocks, along with the VCO, form a Phase-Locked Loop (PLL) that tracks the incoming REF signal.

### VCO and Time Unit Generator

The VCO accepts analog control inputs from the PLL filter block and generates a frequency that is used by the time unit generator to create discrete time units that are selected in the skew select matrix. The operational range of the VCO is determined by the FS control pin. The time unit ( $t_U$ ) is determined by the operating frequency of the device and the level of the FS pin as shown in *Table 1*.

**Table 1. Frequency Range Select and  $t_U$  Calculation<sup>[1]</sup>**

FS <sup>[2, 3]</sup>	f <sub>NOM</sub> (MHz)		$t_U = \frac{1}{f_{NOM} \times N}$ where N =	Approximate Frequency (MHz) At Which $t_U = 1.0$ ns
	Min.	Max.		
LOW	15	30	44	22.7
MID	25	50	26	38.5
HIGH	40	80	16	62.5

### Skew Select Matrix

The skew select matrix is comprised of four independent sections. Each section has two low-skew, high-fanout drivers (xQ0, xQ1), and two corresponding three-level function select

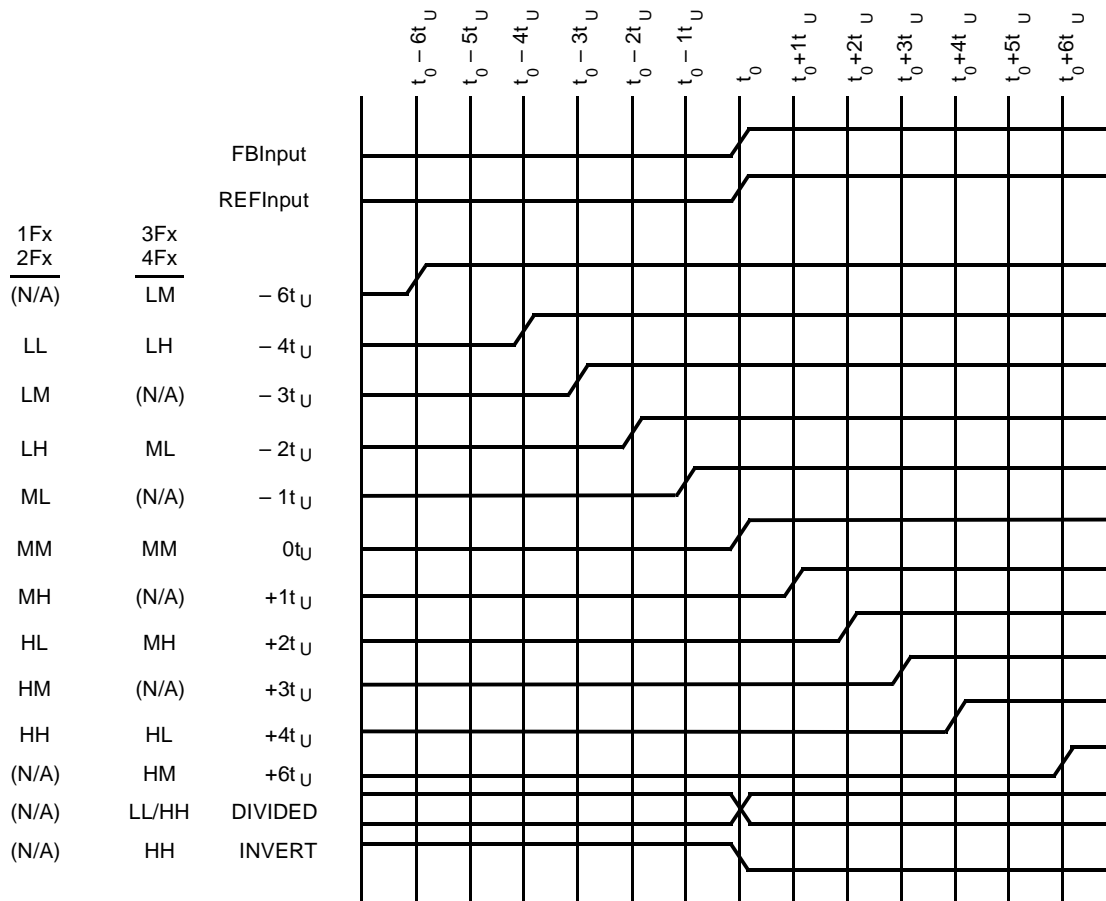
(xF0, xF1) inputs. *Table 2* below shows the nine possible output functions for each section as determined by the function select inputs. All times are measured with respect to the REF input assuming that the output connected to the FB input has 0 $t_U$  selected.

**Table 2. Programmable Skew Configurations<sup>[1]</sup>**

Function Selects		Output Functions		
1F1, 2F1, 3F1, 4F1	1F0, 2F0, 3F0, 4F0	1Q0, 1Q1, 2Q0, 2Q1	3Q0, 3Q1	4Q0, 4Q1
LOW	LOW	-4 $t_U$	Divide by 2	Divide by 2
LOW	MID	-3 $t_U$	-6 $t_U$	-6 $t_U$
LOW	HIGH	-2 $t_U$	-4 $t_U$	-4 $t_U$
MID	LOW	-1 $t_U$	-2 $t_U$	-2 $t_U$
MID	MID	0 $t_U$	0 $t_U$	0 $t_U$
MID	HIGH	+1 $t_U$	+2 $t_U$	+2 $t_U$
HIGH	LOW	+2 $t_U$	+4 $t_U$	+4 $t_U$
HIGH	MID	+3 $t_U$	+6 $t_U$	+6 $t_U$
HIGH	HIGH	+4 $t_U$	Divide by 4	Inverted

#### Notes:

- For all three-state inputs, HIGH indicates a connection to V<sub>CC</sub>, LOW indicates a connection to GND, and MID indicates an open connection. Internal termination circuitry holds an unconnected input to V<sub>CC</sub>/2.
- The level to be set on FS is determined by the "normal" operating frequency (f<sub>NOM</sub>) of the VCO and Time Unit Generator (see Logic Block Diagram). Nominal frequency (f<sub>NOM</sub>) always appears at 1Q0 and the other outputs when they are operated in their undivided modes (see *Table 2*). The frequency appearing at the REF and FB inputs will be f<sub>NOM</sub> when the output connected to FB is undivided. The frequency of the REF and FB inputs will be f<sub>NOM</sub>/2 or f<sub>NOM</sub>/4 when the part is configured for a frequency multiplication by using a divided output as the FB input.
- When the FS pin is selected HIGH, the REF input must not transition upon power-up until V<sub>CC</sub> has reached 4.3V.



7B991-3

**Figure 1. Typical Outputs with FB Connected to a Zero-Skew Output<sup>[4]</sup>**

## Test Mode

The TEST input is a three-level input. In normal system operation, this pin is connected to ground, allowing the CY7B991/CY7B992 to operate as explained briefly above (for testing purposes, any of the three-level inputs can have a removable jumper to ground, or be tied LOW through a 100Ω resistor. This will allow an external tester to change the state of these pins.)

If the TEST input is forced to its MID or HIGH state, the device will operate with its internal phase locked loop disconnected, and input levels supplied to REF will directly control all outputs. Relative output to output functions are the same as in normal mode.

In contrast with normal operation (TEST tied LOW). All outputs will function based only on the connection of their own function select inputs (xF0 and xF1) and the waveform characteristics of the REF input.

## Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature ..... -65°C to +150°C

Ambient Temperature with	
Power Applied .....	-55°C to +125°C
Supply Voltage to Ground Potential .....	-0.5V to +7.0V
DC Input Voltage .....	-0.5V to +7.0V
Output Current into Outputs (LOW) .....	64 mA
Static Discharge Voltage .....	>2001V
(per MIL-STD-883, Method 3015)	
Latch-Up Current .....	>200 mA

## Operating Range

Range	Ambient Temperature	V <sub>CC</sub>
Commercial	0°C to +70°C	5V ± 10%
Industrial	-40°C to +85°C	5V ± 10%
Military <sup>[5]</sup>	-55°C to +125°C	5V ± 10%

### Notes:

4. FB connected to an output selected for "zero" skew (i.e., xF1 = xF0 = MID).
5. Indicates case temperature.

**Electrical Characteristics** Over the Operating Range<sup>[6]</sup>

Parameter	Description	Test Conditions	CY7B991		CY7B992		Unit
			Min.	Max.	Min.	Max.	
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> = Min., I <sub>OH</sub> = -16 mA	2.4				V
		V <sub>CC</sub> = Min., I <sub>OH</sub> = -40 mA			V <sub>CC</sub> - 0.75		
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> = Min., I <sub>OL</sub> = 46 mA		0.45			V
		V <sub>CC</sub> = Min., I <sub>OL</sub> = 46 mA				0.45	
V <sub>IH</sub>	Input HIGH Voltage (REF and FB inputs only)		2.0	V <sub>CC</sub>	V <sub>CC</sub> - 1.35	V <sub>CC</sub>	V
V <sub>IL</sub>	Input LOW Voltage (REF and FB inputs only)		-0.5	0.8	-0.5	1.35	V
V <sub>IHH</sub>	Three-Level Input HIGH Voltage (Test, FS, xFn) <sup>[7]</sup>	Min. ≤ V <sub>CC</sub> ≤ Max.	V <sub>CC</sub> - 0.85	V <sub>CC</sub>	V <sub>CC</sub> - 0.85	V <sub>CC</sub>	V
V <sub>IMM</sub>	Three-Level Input MID Voltage (Test, FS, xFn) <sup>[7]</sup>	Min. ≤ V <sub>CC</sub> ≤ Max.	V <sub>CC</sub> /2 - 500 mV	V <sub>CC</sub> /2 + 500 mV	V <sub>CC</sub> /2 - 500 mV	V <sub>CC</sub> /2 + 500 mV	V
V <sub>ILL</sub>	Three-Level Input LOW Voltage (Test, FS, xFn) <sup>[7]</sup>	Min. ≤ V <sub>CC</sub> ≤ Max.	0.0	0.85	0.0	0.85	V
I <sub>IH</sub>	Input HIGH Leakage Current (REF and FB inputs only)	V <sub>CC</sub> = Max., V <sub>IN</sub> = Max.		10		10	μA
I <sub>IL</sub>	Input LOW Leakage Current (REF and FB inputs only)	V <sub>CC</sub> = Max., V <sub>IN</sub> = 0.4V	-500		-500		μA
I <sub>IHH</sub>	Input HIGH Current (Test, FS, xFn)	V <sub>IN</sub> = V <sub>CC</sub>		200		200	μA
I <sub>IMM</sub>	Input MID Current (Test, FS, xFn)	V <sub>IN</sub> = V <sub>CC</sub> /2	-50	50	-50	50	μA
I <sub>ILL</sub>	Input LOW Current (Test, FS, xFn)	V <sub>IN</sub> = GND		-200		-200	μA
I <sub>OS</sub>	Output Short Circuit Current <sup>[8]</sup>	V <sub>CC</sub> = Max., V <sub>OUT</sub> = GND (25°C only)		-250		N/A	mA
I <sub>CCQ</sub>	Operating Current Used by Internal Circuitry	V <sub>CCN</sub> = V <sub>CCQ</sub> = Max., All Input Selects Open	Com'I	85		85	mA
			Mil/Ind	90		90	
I <sub>CCN</sub>	Output Buffer Current per Output Pair <sup>[9]</sup>	V <sub>CCN</sub> = V <sub>CCQ</sub> = Max., I <sub>OUT</sub> = 0 mA Input Selects Open, f <sub>MAX</sub>		14		19	mA
PD	Power Dissipation per Output Pair <sup>[10]</sup>	V <sub>CCN</sub> = V <sub>CCQ</sub> = Max., I <sub>OUT</sub> = 0 mA Input Selects Open, f <sub>MAX</sub>		78		104 <sup>[11]</sup>	mW

**Notes:**

- See the last page of this specification for Group A subgroup testing information.
- These inputs are normally wired to V<sub>CC</sub>, GND, or left unconnected (actual threshold voltages vary as a percentage of V<sub>CC</sub>). Internal termination resistors hold unconnected inputs at V<sub>CC</sub>/2. If these inputs are switched, the function and timing of the outputs may glitch and the PLL may require an additional t<sub>LOCK</sub> time before all datasheet limits are achieved.
- CY7B991 should be tested one output at a time, output shorted for less than one second, less than 10% duty cycle. Room temperature only. CY7B992 outputs should not be shorted to GND. Doing so may cause permanent damage.
- Total output current per output pair can be approximated by the following expression that includes device current plus load current:  
CY7B991: I<sub>CCN</sub> = [(4 + 0.11F) + (((835 - 3F)/Z) + (.0022FC))N] x 1.1  
CY7B992: I<sub>CCN</sub> = [(3.5 + 0.17F) + (((1160 - 2.8F)/Z) + (.0025FC))N] x 1.1  
Where  
F = frequency in MHz  
C = capacitive load in pF  
Z = line impedance in ohms  
N = number of loaded outputs; 0, 1, or 2  
FC = F < C
- Total power dissipation per output pair can be approximated by the following expression that includes device power dissipation plus power dissipation due to the load circuit:  
CY7B991: PD = [(22 + 0.61F) + (((1550 - 2.7F)/Z) + (.0125FC))N] x 1.1  
CY7B992: PD = [(19.25 + 0.94F) + (((700 + 6F)/Z) + (.017FC))N] x 1.1  
See note 9 for variable definition.
- CMOS output buffer current and power dissipation specified at 50-MHz reference frequency.

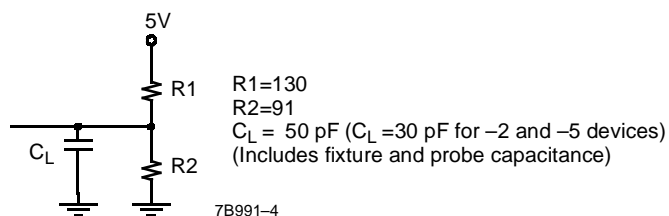
## Capacitance<sup>[12]</sup>

Parameter	Description	Test Conditions	Max.	Unit
$C_{IN}$	Input Capacitance	$T_A = 25^\circ\text{C}$ , $f = 1\text{ MHz}$ , $V_{CC} = 5.0\text{V}$	10	pF

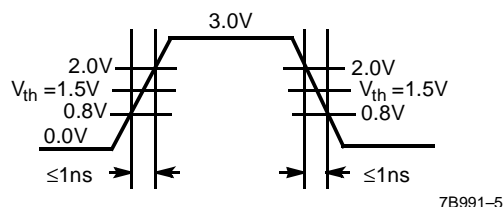
**Note:**

12. Applies to REF and FB inputs only. Tested initially and after any design or process changes that may affect these parameters.

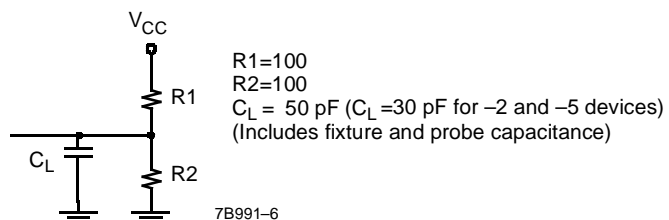
## AC Test Loads and Waveforms



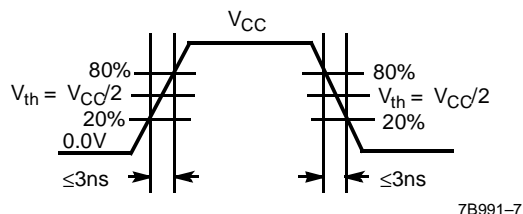
**TTL AC Test Load (CY7B991)**



**TTL Input Test Waveform (CY7B991)**



**CMOS AC Test Load (CY7B992)**



**CMOS Input Test Waveform (CY7B992)**

**Switching Characteristics** Over the Operating Range<sup>[2, 13]</sup>

Parameter	Description		CY7B991-2 <sup>[14]</sup>			CY7B992-2 <sup>[14]</sup>			Unit
			Min.	Typ.	Max.	Min.	Typ.	Max.	
f <sub>NOM</sub>	Operating Clock Frequency in MHz	FS = LOW <sup>[1, 2]</sup>	15		30	15		30	MHz
		FS = MID <sup>[1, 2]</sup>	25		50	25		50	
		FS = HIGH <sup>[1, 2, 3]</sup>	40		80	40		80 <sup>[15]</sup>	
t <sub>RPWH</sub>	REF Pulse Width HIGH		5.0			5.0			ns
t <sub>RPWL</sub>	REF Pulse Width LOW		5.0			5.0			ns
t <sub>U</sub>	Programmable Skew Unit		See Table 1						
t <sub>SKEWPR</sub>	Zero Output Matched-Pair Skew (XQ0, XQ1) <sup>[16, 17]</sup>			0.05	0.20		0.05	0.20	ns
t <sub>SKEW0</sub>	Zero Output Skew (All Outputs) <sup>[16, 18, 19]</sup>			0.1	0.25		0.1	0.25	ns
t <sub>SKEW1</sub>	Output Skew (Rise-Rise, Fall-Fall, Same Class Outputs) <sup>[16, 20]</sup>			0.25	0.5		0.25	0.5	ns
t <sub>SKEW2</sub>	Output Skew (Rise-Fall, Nominal-Inverted, Divided-Divided) <sup>[16, 20]</sup>			0.3	0.5		0.3	0.5	ns
t <sub>SKEW3</sub>	Output Skew (Rise-Rise, Fall-Fall, Different Class Outputs) <sup>[16, 20]</sup>			0.25	0.5		0.25	0.5	ns
t <sub>SKEW4</sub>	Output Skew (Rise-Fall, Nominal-Divided, Divided-Inverted) <sup>[16, 20]</sup>			0.5	0.9		0.5	0.7	ns
t <sub>DEV</sub>	Device-to-Device Skew <sup>[14, 21]</sup>				0.75			0.75	ns
t <sub>PD</sub>	Propagation Delay, REF Rise to FB Rise		-0.25	0.0	+0.25	-0.25	0.0	+0.25	ns
t <sub>ODCV</sub>	Output Duty Cycle Variation <sup>[22]</sup>		-0.65	0.0	+0.65	-0.5	0.0	+0.5	ns
t <sub>PWH</sub>	Output HIGH Time Deviation from 50% <sup>[23, 24]</sup>				2.0			3.0	ns
t <sub>PWL</sub>	Output LOW Time Deviation from 50% <sup>[23, 24]</sup>				1.5			3.0	ns
t <sub>ORISE</sub>	Output Rise Time <sup>[23, 25]</sup>		0.15	1.0	1.2	0.5	2.0	2.5	ns
t <sub>OFALL</sub>	Output Fall Time <sup>[23, 25]</sup>		0.15	1.0	1.2	0.5	2.0	2.5	ns
t <sub>LOCK</sub>	PLL Lock Time <sup>[26]</sup>				0.5			0.5	ms
t <sub>JR</sub>	Cycle-to-Cycle Output Jitter	RMS <sup>[14]</sup>			25			25	ps
		Peak-to-Peak <sup>[14]</sup>			200			200	ps

**Note:**

13. Test measurement levels for the CY7B991 are TTL levels (1.5V to 1.5V). Test measurement levels for the CY7B992 are CMOS levels ( $V_{CC}/2$  to  $V_{CC}/2$ ). Test conditions assume signal transition times of 2 ns or less and output loading as shown in the AC Test Loads and Waveforms unless otherwise specified.
14. Guaranteed by statistical correlation. Tested initially and after any design or process changes that may affect these parameters.
15. Except as noted, all CY7B992-2 and -5 timing parameters are specified to 80-MHz with a 30-pF load.
16. SKEW is defined as the time between the earliest and the latest output transition among all outputs for which the same  $t_U$  delay has been selected when all are loaded with 50 pF and terminated with 50Ω to 2.06V (CY7B991) or  $V_{CC}/2$  (CY7B992).
17.  $t_{SKEWPR}$  is defined as the skew between a pair of outputs (XQ0 and XQ1) when all eight outputs are selected for  $0t_U$ .
18.  $t_{SKEW0}$  is defined as the skew between outputs when they are selected for  $0t_U$ . Other outputs are divided or inverted but not shifted.
19.  $C_L = 0$  pF. For  $C_L = 30$  pF,  $t_{SKEW0} = 0.35$  ns.
20. There are three classes of outputs: Nominal (multiple of  $t_U$  delay), Inverted (4Q0 and 4Q1 only with 4F0 = 4F1 = HIGH), and Divided (3Qx and 4Qx only in Divide-by-2 or Divide-by-4 mode).
21.  $t_{DEV}$  is the output-to-output skew between any two devices operating under the same conditions ( $V_{CC}$  ambient temperature, air flow, etc.)
22.  $t_{ODCV}$  is the deviation of the output from a 50% duty cycle. Output pulse width variations are included in  $t_{SKEW2}$  and  $t_{SKEW4}$  specifications.
23. Specified with outputs loaded with 30 pF for the CY7B99X-2 and -5 devices and 50 pF for the CY7B99X-7 devices. Devices are terminated through 50Ω to 2.06V (CY7B991) or  $V_{CC}/2$  (CY7B992).
24.  $t_{PWH}$  is measured at 2.0V for the CY7B991 and 0.8  $V_{CC}$  for the CY7B992.  $t_{PWL}$  is measured at 0.8V for the CY7B991 and 0.2  $V_{CC}$  for the CY7B992.
25.  $t_{ORISE}$  and  $t_{OFALL}$  measured between 0.8V and 2.0V for the CY7B991 or 0.8  $V_{CC}$  and 0.2  $V_{CC}$  for the CY7B992.
26.  $t_{LOCK}$  is the time that is required before synchronization is achieved. This specification is valid only after  $V_{CC}$  is stable and within normal operating limits. This parameter is measured from the application of a new signal or frequency at REF or FB until  $t_{PD}$  is within specified limits.

**Switching Characteristics** Over the Operating Range<sup>[2, 13]</sup> (continued)

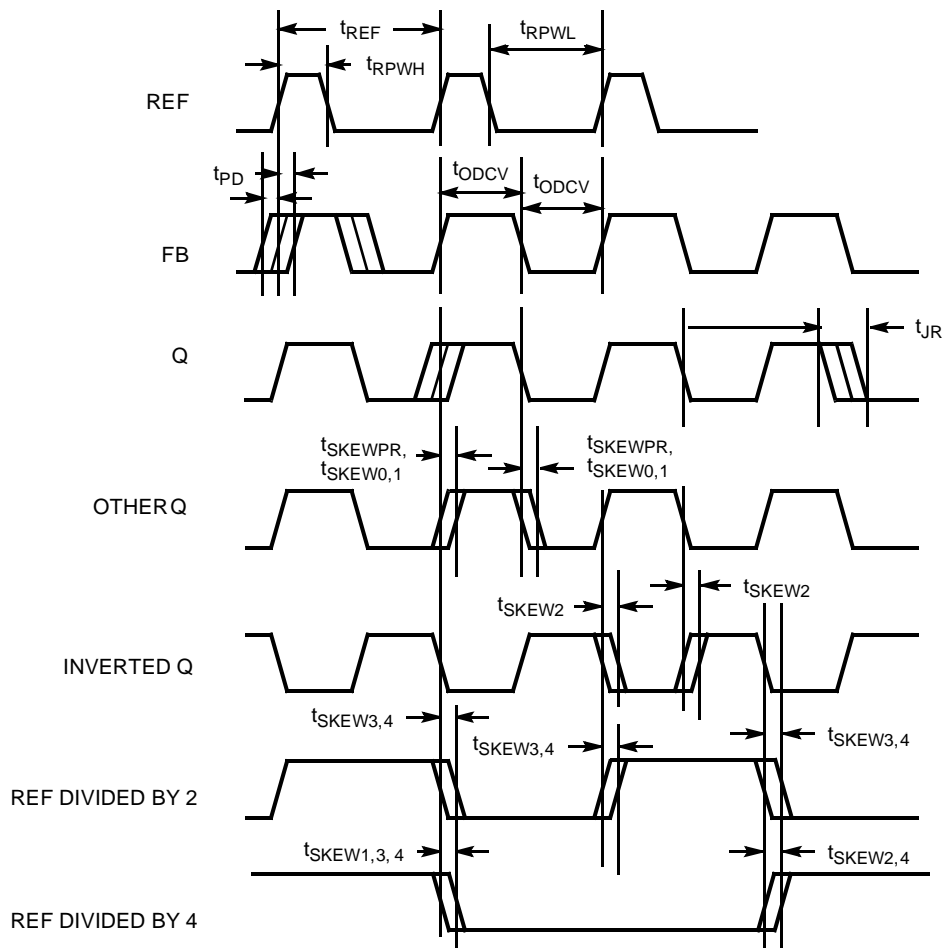
Parameter	Description		CY7B991-5			CY7B992-5			Unit
			Min.	Typ.	Max.	Min.	Typ.	Max.	
f <sub>NOM</sub>	Operating Clock Frequency in MHz	FS = LOW <sup>[1, 2]</sup>	15		30	15		30	MHz
		FS = MID <sup>[1, 2]</sup>	25		50	25		50	
		FS = HIGH <sup>[1, 2, 3]</sup>	40		80	40		80 <sup>[15]</sup>	
t <sub>RPWH</sub>	REF Pulse Width HIGH		5.0			5.0			ns
t <sub>RPWL</sub>	REF Pulse Width LOW		5.0			5.0			ns
t <sub>U</sub>	Programmable Skew Unit		See Table 1						
t <sub>SKEWPR</sub>	Zero Output Matched-Pair Skew (XQ0, XQ1) <sup>[16, 17]</sup>			0.1	0.25		0.1	0.25	ns
t <sub>SKEW0</sub>	Zero Output Skew (All Outputs) <sup>[16, 18]</sup>			0.25	0.5		0.25	0.5	ns
t <sub>SKEW1</sub>	Output Skew (Rise-Rise, Fall-Fall, Same Class Outputs) <sup>[16, 20]</sup>			0.6	0.7		0.6	0.7	ns
t <sub>SKEW2</sub>	Output Skew (Rise-Fall, Nominal-Inverted, Divided-Divided) <sup>[16, 20]</sup>			0.5	1.0		0.6	1.5	ns
t <sub>SKEW3</sub>	Output Skew (Rise-Rise, Fall-Fall, Different Class Outputs) <sup>[16, 20]</sup>			0.5	0.7		0.5	0.7	ns
t <sub>SKEW4</sub>	Output Skew (Rise-Fall, Nominal-Divided, Divided-Inverted) <sup>[16, 20]</sup>			0.5	1.0		0.6	1.7	ns
t <sub>DEV</sub>	Device-to-Device Skew <sup>[14, 21]</sup>				1.25			1.25	ns
t <sub>PD</sub>	Propagation Delay, REF Rise to FB Rise		-0.5	0.0	+0.5	-0.5	0.0	+0.5	ns
t <sub>ODCV</sub>	Output Duty Cycle Variation <sup>[22]</sup>		-1.0	0.0	+1.0	-1.2	0.0	+1.2	ns
t <sub>PWH</sub>	Output HIGH Time Deviation from 50% <sup>[23, 24]</sup>				2.5			4.0	ns
t <sub>PWL</sub>	Output LOW Time Deviation from 50% <sup>[23, 24]</sup>				3			4.0	ns
t <sub>ORISE</sub>	Output Rise Time <sup>[23, 25]</sup>		0.15	1.0	1.5	0.5	2.0	3.5	ns
t <sub>OFALL</sub>	Output Fall Time <sup>[23, 25]</sup>		0.15	1.0	1.5	0.5	2.0	3.5	ns
t <sub>LOCK</sub>	PLL Lock Time <sup>[26]</sup>				0.5			0.5	ms
t <sub>JR</sub>	Cycle-to-Cycle Output Jitter	RMS <sup>[14]</sup>			25			25	ps
		Peak-to-Peak <sup>[14]</sup>			200			200	ps

**Switching Characteristics** Over the Operating Range<sup>[2, 13]</sup> (continued)

Parameter	Description		CY7B991-7			CY7B992-7			Unit
			Min.	Typ.	Max.	Min.	Typ.	Max.	
f <sub>NOM</sub>	Operating Clock Frequency in MHz	FS = LOW <sup>[1, 2]</sup>	15		30	15		30	MHz
		FS = MID <sup>[1, 2]</sup>	25		50	25		50	
		FS = HIGH <sup>[1, 2]</sup>	40		80	40		80 <sup>[15]</sup>	
t <sub>RPWH</sub>	REF Pulse Width HIGH		5.0			5.0			ns
t <sub>RPWL</sub>	REF Pulse Width LOW		5.0			5.0			ns
t <sub>U</sub>	Programmable Skew Unit		See Table 1						
t <sub>SKEWPR</sub>	Zero Output Matched-Pair Skew (XQ0, XQ1) <sup>[16, 17]</sup>			0.1	0.25		0.1	0.25	ns
t <sub>SKEW0</sub>	Zero Output Skew (All Outputs) <sup>[16, 18]</sup>			0.3	0.75		0.3	0.75	ns
t <sub>SKEW1</sub>	Output Skew (Rise-Rise, Fall-Fall, Same Class Outputs) <sup>[16, 20]</sup>			0.6	1.0		0.6	1.0	ns
t <sub>SKEW2</sub>	Output Skew (Rise-Fall, Nominal-Inverted, Divided-Divided) <sup>[16, 20]</sup>			1.0	1.5		1.0	1.5	ns
t <sub>SKEW3</sub>	Output Skew (Rise-Rise, Fall-Fall, Different Class Outputs) <sup>[16, 20]</sup>			0.7	1.2		0.7	1.2	ns
t <sub>SKEW4</sub>	Output Skew (Rise-Fall, Nominal-Divided, Divided-Inverted) <sup>[16, 20]</sup>			1.2	1.7		1.2	1.7	ns
t <sub>DEV</sub>	Device-to-Device Skew <sup>[14, 21]</sup>				1.65			1.65	ns
t <sub>PD</sub>	Propagation Delay, REF Rise to FB Rise		-0.7	0.0	+0.7	-0.7	0.0	+0.7	ns
t <sub>ODCV</sub>	Output Duty Cycle Variation <sup>[22]</sup>		-1.2	0.0	+1.2	-1.5	0.0	+1.5	ns
t <sub>PWH</sub>	Output HIGH Time Deviation from 50% <sup>[23, 24]</sup>				3			5.5	ns
t <sub>PWL</sub>	Output LOW Time Deviation from 50% <sup>[23, 24]</sup>				3.5			5.5	ns
t <sub>ORISE</sub>	Output Rise Time <sup>[23, 25]</sup>		0.15	1.5	2.5	0.5	3.0	5.0	ns
t <sub>OFALL</sub>	Output Fall Time <sup>[23, 25]</sup>		0.15	1.5	2.5	0.5	3.0	5.0	ns
t <sub>LOCK</sub>	PLL Lock Time <sup>[26]</sup>				0.5			0.5	ms
t <sub>JR</sub>	Cycle-to-Cycle Output Jitter	RMS <sup>[14]</sup>			25			25	ps
		Peak-to-Peak <sup>[14]</sup>			200			200	ps

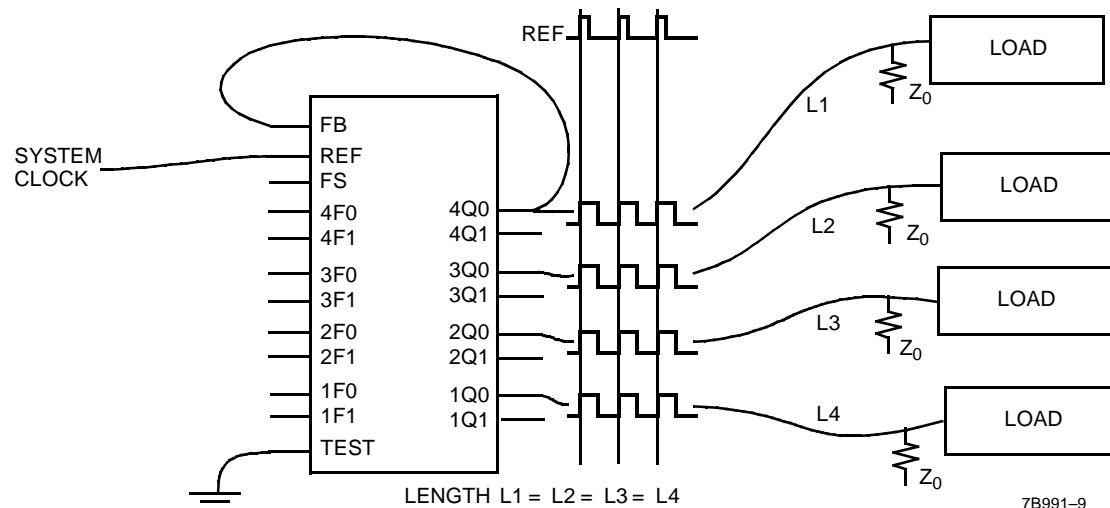


## AC Timing Diagrams



7B991-8

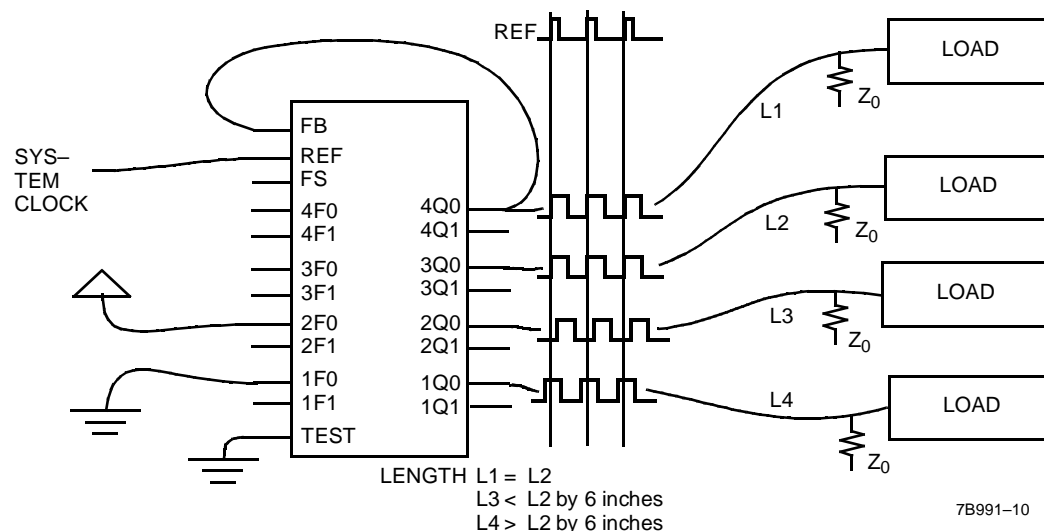
## Operational Mode Descriptions



**Figure 2. Zero-Skew and/or Zero-Delay Clock Driver**

Figure 2 shows the PSCB configured as a zero-skew clock buffer. In this mode the 7B991/992 can be used as the basis for a low-skew clock distribution tree. When all of the function select inputs (xF0, xF1) are left open, the outputs are aligned and may each drive a terminated transmission line to an independent load. The FB input can be tied to any output in this

configuration and the operating frequency range is selected with the FS pin. The low-skew specification, coupled with the ability to drive terminated transmission lines (with impedances as low as 50 ohms), allows efficient printed circuit board design.



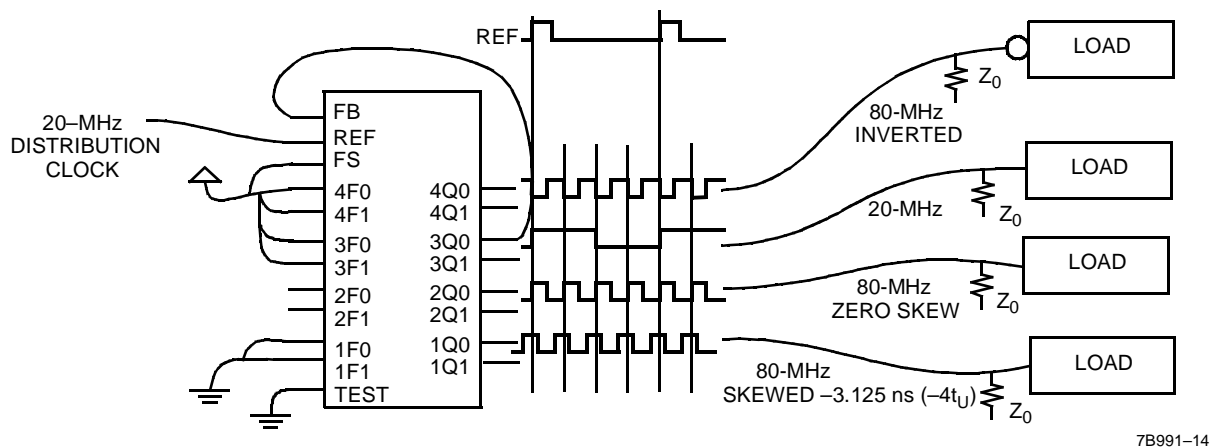
**Figure 3. Programmable-Skew Clock Driver**

Figure 3 shows a configuration to equalize skew between metal traces of different lengths. In addition to low skew between outputs, the PSCB can be programmed to stagger the timing of its outputs. The four groups of output pairs can each be programmed to different output timing. Skew timing can be adjusted over a wide range in small increments with the appropriate strapping of the function select pins. In this configuration the 4Q0 output is fed back to FB and configured for zero skew. The other three pairs of outputs are programmed to yield different skews relative to the feedback. By advancing the clock signal on the longer traces or retarding the clock signal on shorter traces, all loads can receive the clock pulse at the same time.

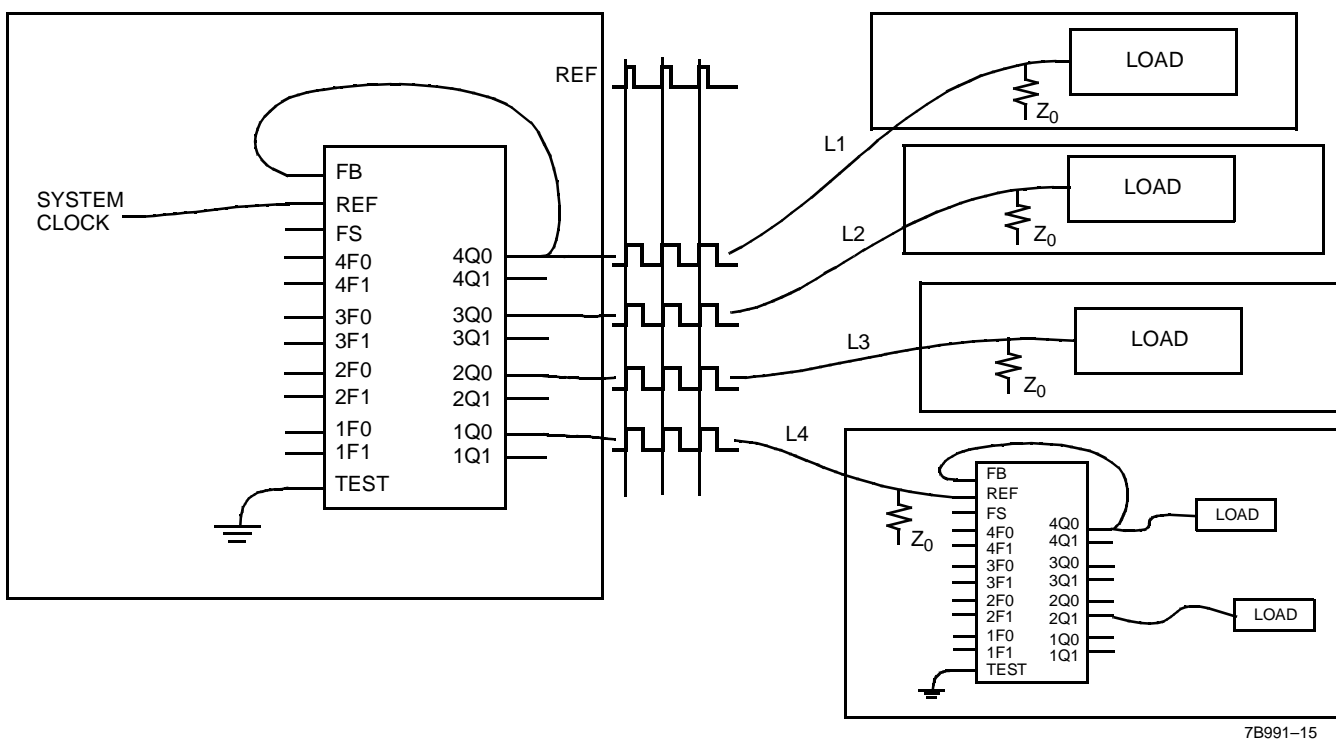
In this illustration the FB input is connected to an output with 0-ns skew (xF1, xF0 = MID) selected. The internal PLL synchronizes the FB and REF inputs and aligns their rising edges to insure that all outputs have precise phase alignment.

Clock skews can be advanced by  $\pm 6$  time units ( $t_U$ ) when using an output selected for zero skew as the feedback. A wider range of delays is possible if the output connected to FB is also skewed. Since "Zero Skew",  $+t_U$ , and  $-t_U$  are defined relative to output groups, and since the PLL aligns the rising edges of REF and FB, it is possible to create wider output skews by proper selection of the xFn inputs. For example a  $+10 t_U$  between REF and 3Qx can be achieved by connecting 1Q0 to FB and setting 1F0 = 1F1 = GND,





**Figure 7. Multi-Function Clock Driver**



**Figure 8. Board-to-Board Clock Distribution**

Figure 8 shows the CY7B991/992 connected in series to construct a zero-skew clock distribution tree between boards. Delays of the downstream clock buffers can be programmed to compensate for the wire length (i.e., select negative skew equal to the wire delay) necessary to connect them to the mas-

ter clock source, approximating a zero-delay clock tree. Cascaded clock buffers will accumulate low-frequency jitter because of the non-ideal filtering characteristics of the PLL filter. It is recommended that not more than two clock buffers be connected in series.

## Ordering Information

Accuracy (ps)	Ordering Code	Package Name	Package Type	Operating Range
250	CY7B991-2JC	J65	32-Lead Plastic Leaded Chip Carrier	Commercial
500	CY7B991-5JC	J65	32-Lead Plastic Leaded Chip Carrier	Commercial
	CY7B991-5JI	J65	32-Lead Plastic Leaded Chip Carrier	Industrial
750	CY7B991-7JC	J65	32-Lead Plastic Leaded Chip Carrier	Commercial
	CY7B991-7JI	J65	32-Lead Plastic Leaded Chip Carrier	Industrial
	CY7B991-7LMB	L55	32-Pin Rectangular Leadless Chip Carrier	Military
250	CY7B992-2JC	J65	32-Lead Plastic Leaded Chip Carrier	Commercial
500	CY7B992-5JC	J65	32-Lead Plastic Leaded Chip Carrier	Commercial
	CY7B992-5JI	J65	32-Lead Plastic Leaded Chip Carrier	Industrial
750	CY7B992-7JC	J65	32-Lead Plastic Leaded Chip Carrier	Commercial
	CY7B992-7JI	J65	32-Lead Plastic Leaded Chip Carrier	Industrial
	CY7B992-7LMB	L55	32-Pin Rectangular Leadless Chip Carrier	Military

## MILITARY SPECIFICATIONS

### Group A Subgroup Testing

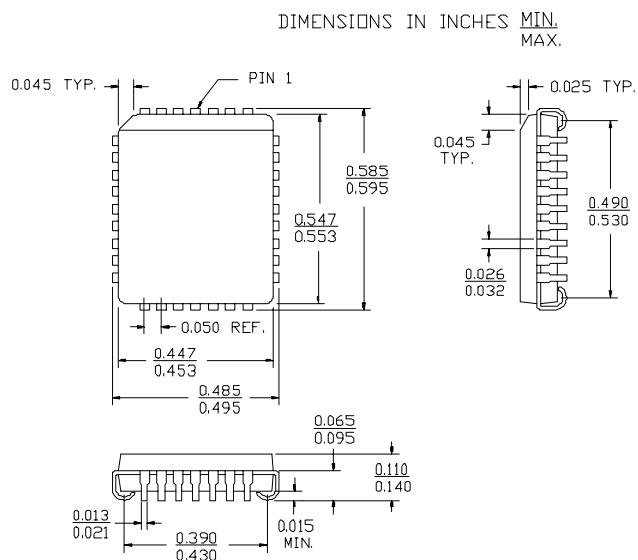
## DC Characteristics

Parameter	Subgroups
$V_{OH}$	1, 2, 3
$V_{OL}$	1, 2, 3
$V_{IH}$	1, 2, 3
$V_{IL}$	1, 2, 3
$V_{IHH}$	1, 2, 3
$V_{IMM}$	1, 2, 3
$V_{ILL}$	1, 2, 3
$I_{IH}$	1, 2, 3
$I_{IL}$	1, 2, 3
$I_{IHH}$	1, 2, 3
$I_{IMM}$	1, 2, 3
$I_{ILL}$	1, 2, 3
$I_{CCQ}$	1, 2, 3
$I_{CCN}$	1, 2, 3

Document #: 38-00513-A

## Package Diagrams

### 32-Lead Plastic Leaded Chip Carrier



### 32-Pin Rectangular Leadless Chip Carrier MIL-STD-1835 C-12

